

Mask Set Errata for Mask 3N96B

This document contains a subset of errata for Kinetis Mask Set 3N96B. Errata for security-related modules are not included in this document and are only available after a nondisclosure agreement (NDA) has been signed.

For more information on obtaining an NDA and viewing the comprehensive errata list for this mask set, please contact your local Freescale sales representative.

Mask Set Errata for Mask 3N96B

This report applies to mask 3N96B for these products:

- MK10FX512xxx12, MK10FN1M0xxx12
- MK20FX512xxx12, MK20FN1M0xxx12
- MK60FX512xxx12, MK60FN1M0xxx12, MK60FX512xxx15, MK60FN1M0xxx15
- MK61FX512xxx12, MK61FN1M0xxx12, MK61FX512xxx15, MK61FN1M0xxx15
- MK70FX512xxx12, MK70FN1M0xxx12, MK70FX512xxx15, MK70FN1M0xxx15

Table 1. Errata and Information Summary

Erratum ID	Erratum Title
e8992	AWIC: Early NMI wakeup not detected upon entry to stop mode from VLPR mode
e6378	Cache: Cache write buffer error enable (MCM_ISCR[CWBEE]) does not work
e6804	CJTAG: Performing a mode change from Standard Protocol to Advanced Protocol may reset the CJTAG.
e6990	CJTAG: possible incorrect TAP state machine advance during Check Packet
e6939	Core: Interrupted loads to SP can cause erroneous behavior
e9005	Core: Store immediate overlapping exception return operation might vector to incorrect interrupt
e6940	Core: VDIV or VSQRT instructions might not complete correctly when very short ISRs are used
e9296	DDR: differential clock cross point voltage and clock pulse width specs not met by all devices
e10521	DDR: In rare cases, one DDR byte lane can stop working correctly
e5243	DDRM: It is possible for data corruption to occur if the value programmed in RDLATADJ is larger than the CAS latency,
e5241	DDRM: Putting the memory into a power down mode while DDR_CR11[AREFMODE] is set can prevent the DDRM from providing refreshes to the memory while it is powered down.
e5263	DDRM: While the memory is in a power down state, setting DDR_CR11[AREF] in an attempt to force a refresh command will cause a refresh cycle to be missed.
e4588	DMAMUX: When using PIT with "always enabled" request, DMA request does not deassert correctly
e6933	eDMA: Possible misbehavior of a preempted channel when using continuous link mode
e10066	eDMA: UART0 and UART1 peripheral requests trigger DMA twice if core clock and internal bus clock frequencies are equal
e6358	ENET: Write to Transmit Descriptor Active Register (ENET_TDAR) is ignored

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Table 1. Errata and Information Summary (continued)

Erratum ID	Erratum Title
e9595	FlexCAN: Corrupted frame possible if Freeze Mode or Low Power Mode are entered during a Bus-Off state
e5641	FlexCAN: Module does not transmit a message that is enabled to be transmitted at a specific moment during the arbitration process.
e9527	FlexCAN: The transmission abort mechanism may not work properly
e5861	FTM: FTM2 and FTM3 do not correctly enter BDM mode when a debugger connection is active
e4710	FTM: FTMx_PWMLOAD register does not support 8-/16-bit accesses
e9265	FTM: Incorrect match may be generated if intermediate load feature is used in toggle mode
e6484	FTM: The process of clearing the FTMx_SC[TOF] bit does not work as expected under a certain condition when the FTM counter reaches FTM_MOD value.
e9004	ITM can deadlock when global timestamping is enabled
e6573	JTAG: JTAG TDO function on the PTA2 disables the pull resistor
e4553	LCDC: Cursor Color Limited in 24bpp Mode
e4569	LCDC: Graphic Window Color Key Limited in 24bpp Mode
e4570	LCDC: Graphic Window May Shift Pixel Data
e4571	LCDC: LCDC can only use half of internal SRAM for frame buffer
e8010	LLWU: CMP flag in LLWU_Fx register cleared by multiple CMP out toggles when exiting LLSx or VLLSx modes.
e7993	MCG: FLL frequency may be incorrect after changing the FLL reference clock
e7735	MCG: IREFST status bit may set before the IREFS multiplexor switches the FLL reference clock
e3898	MCG: Setting the MCG_C6[PLLS] bit will enable both OSC0 and OSC1.
e4590	MCG: Transitioning from VLPS to VLPR low power modes while in BLPI clock mode is not supported.
e4176	NMI: NMI interrupt service routine (ISR) might not be called when MCU wakes up from VLLSx modes.
e3794	NVIC: NMI interrupt does not wakeup MCU from STOP and VLPS
e5927	Operating requirements: Change to minimum VDD spec
e9697	PMC: Possible power on resets when VDDINT and VDD are not at the same voltage
e5667	PMC: When used as an input to ADC or CMP modules, the PMC bandgap 1-V voltage reference is not available in VLPx, LLS, or VLLSx modes
e9293	PORT: Internal pull resistors not enabled for all pin functions
e5130	SAI: Under certain conditions, the CPU cannot reenter STOP mode via an asynchronous interrupt wakeup event
e3981	SDHC: ADMA fails when data length in the last descriptor is less or equal to 4 bytes
e3982	SDHC: ADMA transfer error when the block size is not a multiple of four
e4624	SDHC: AutoCMD12 and R1b polling problem
e3977	SDHC: Does not support Infinite Block Transfer Mode
e4627	SDHC: Erroneous CMD CRC error and CMD Index error may occur on sending new CMD during data transfer
e3984	SDHC: eSDHC misses SDIO interrupt when CINT is disabled
e3980	SDHC: Glitch is generated on card clock with software reset or clock divider change
e6934	SDHC: Issues with card removal/insertion detection
e3983	SDHC: Problem when ADMA2 last descriptor is LINK or NOP

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Table 1. Errata and Information Summary (continued)

Erratum ID	Erratum Title
e3978	SDHC: Software can not clear DMA interrupt status bit after read operation
e3941	SIM/DDR: SIM_SOPT2[FBSL] does not determine allowable DDR controller accesses when security is enabled
e4218	SIM/FLEXBUS: SIM_SCGC7[FLEXBUS] bit should be cleared when the FlexBus is not being used.
e5952	SMC: Wakeup via the LLWU from LLS/VLLS to RUN to VLPR incorrectly triggers an immediate wakeup from the next low power mode entry
e7166	SOC: SDHC, NFC, USBOTG, and cache modules are not clocked correctly in low-power modes
e9682	SPI: Inconsistent loading of shift register data into the receive FIFO following an overflow event
e2638	TSI: The counter registers are not immediately updated after the EOSF bit is set.
e4546	TSI: The counter values reported from TSI increase when in low power modes (LLS, VLLS1, VLLS2, VLLS3)
e3926	TSI: The TSI will run several scan cycles during reference clock instead of scanning each electrode once
e4181	TSI: When the overrun flag is set, the TSI scanning sequence will exhibit undefined behavior.
e4935	UART: CEA709.1 features not supported
e7028	UART: During ISO-7816 initial character detection the parity, framing, and noise error flags can set
e7027	UART: During ISO-7816 T=0 initial character detection invalid initial characters are stored in the RxFIFO
e8184	UART: During ISO-7816 T=0, TC bit set at 12 ETUs may cause loss of characters when UART is switched from transmit to receive mode
e6472	UART: ETU compensation needed for ISO-7816 wait time (WT) and block wait time (BWT)
e4647	UART: Flow control timing issue can result in loss of characters if FIFO is not enabled
e7090	UART: In ISO-7816 mode, timer interrupts flags do not clear
e7029	UART: In ISO-7816 T=1 mode, CWT interrupts assert at both character and block boundaries
e7031	UART: In single wire receive mode UART will attempt to transmit if data is written to UART_D
e3892	UART: ISO-7816 automatic initial character detect feature not working correctly
e4945	UART: ISO-7816 T=1 mode receive data format with a single stop bit is not supported
e5704	UART: TC bit in UARTx_S1 register is set before the last character is sent out in ISO7816 T=0 mode
e7091	UART: UART_S1[NF] and UART_S1[PE] can set erroneously while UART_S1[FE] is set
e7092	UART: UART_S1[TC] is not cleared by queuing a preamble or break character
e8807	USB: In Host mode, transmission errors may occur when communicating with a Low Speed (LS) device through a USB hub
e5928	USBOTG: USBx_USBTTC0[USBRESET] bit does not operate as expected in all cases

Table 2. Revision History

Revision	Changes
0	Initial revision
07 AUG 2013	No changes in this revision

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Table 2. Revision History (continued)

Revision	Changes
29 JUL 2016	<p>The following errata were removed.</p> <ul style="list-style-type: none">• e3964 <p>The following errata were added.</p> <ul style="list-style-type: none">• e6804• e10066• e7735• e9265• e9595• e8992• e8807• e8184• e5641• e9682• e9005• e9004• e6990• e7993• e8010• e10521• e9697• e9527• e9293• e9296

e8992: AWIC: Early NMI wakeup not detected upon entry to stop mode from VLPR mode

Description: Upon entry into VLPS from VLPR, if NMI is asserted before the VLPS entry completes, then the NMI does not generate a wakeup to the MCU. However, the NMI interrupt will occur after the MCU wakes up by another wake-up event.

Workaround: There are two workarounds:

- 1) First transition from VLPR mode to RUN mode, and then enter into VLPS mode from RUN mode.
- 2) Assert NMI signal for longer than 16 bus clock cycles.

e6378: Cache: Cache write buffer error enable (MCM_ISCR[CWBEE]) does not work

Description: The CM4 cache contains a one entry write buffer. The one entry write buffer is controlled by the write buffer enable bit in the cache control registers. If enabled, it will buffer all writethrough and non-cacheable writes. Also, if enabled, it will break the direct association between a write bus fault and the processor completing the write (i.e.write fault imprecise).

The processor will then not see this fault. It is possible to enable fault reporting and capture fault information on buffered writes that create bus errors. This logic is in the MCM (Miscellaneous Control Module). The CWBEE (Cache Write Buffer Error Enable) bit in the

MCM_ISCR (Interrupt Status and Control Register) enables an interrupt to be generated on buffered writes that fault. There are also registers in the MCM to capture fault information (address, attributes, write data) plus a sticky bit to indicate a write buffer fault or multiple write buffer bus faults have occurred. This interrupt will be imprecise and occur sometime after the write fault.

However, due to a logic error, the CWBEE function is not working. On write buffer accesses that fault, the write fault address, attributes and data are correctly captured in the MCM fault information registers but even if CWBEE is set, no interrupt is generated.

- Workaround:**
1. If a write buffer is enabled and a write access is being run to an address area that may fault, directly check the Cache Write Buffer Fault indicator in the MCM module.
 2. Don't enable the cache write buffers, keeping all writethrough and non-cacheable write faults precise.

e6804: CJTAG: Performing a mode change from Standard Protocol to Advanced Protocol may reset the CJTAG.

Description: In extremely rare conditions, when performing a mode change from Standard Protocol to Advanced Protocol on the IEEE 1149.7 (Compact JTAG interface), the CJTAG may reset itself. In this case, all internal CJTAG registers will be reset and the CJTAG will return to the Standard Protocol mode.

Workaround: If the CJTAG resets itself while attempting to change modes from Standard Protocol to Advanced Protocol and Advanced Protocol cannot be enabled after several attempts, perform future accesses in Standard Protocol mode and do not use the Advanced Protocol feature.

e6990: CJTAG: possible incorrect TAP state machine advance during Check Packet

Description: While processing a Check Packet, the IEEE 1149.7 module (CJTAG) internally gates the TCK clock to the CJTAG Test Access Port (TAP) controller in order to hold the TAP controller in the Run-Test-Idle state until the Check Packet completes. A glitch on the internally gated TCK could occur during the transition from the Preamble element to the first Body element of Check Packet processing that would cause the CJTAG TAP controller to change states instead of remaining held in Run-Test-Idle

If the CJTAG TAP controller changes states during the Check Packet due to the clock glitch, the CJTAG will lose synchronization with the external tool, preventing further communication.

Workaround: To prevent the possible loss of JTAG synchronization, when processing a Check Packet, provide a logic 0 value on the TMS pin during the Preamble element to avoid a possible glitch on the internally gated TCK clock.

e6939: Core: Interrupted loads to SP can cause erroneous behavior

Description: ARM Errata 752770: Interrupted loads to SP can cause erroneous behavior

This issue is more prevalent for user code written to manipulate the stack. Most compilers will not be affected by this, but please confirm this with your compiler vendor. MQX™ and FreeRTOS™ are not affected by this issue.

Affects: Cortex-M4, Cortex-M4F

Fault Type: Programmer Category B

Fault Status: Present in: r0p0, r0p1 Open.

If an interrupt occurs during the data-phase of a single word load to the stack-pointer (SP/R13), erroneous behavior can occur. In all cases, returning from the interrupt will result in the load instruction being executed an additional time. For all instructions performing an update to the base register, the base register will be erroneously updated on each execution, resulting in the stack-pointer being loaded from an incorrect memory location.

The affected instructions that can result in the load transaction being repeated are:

- 1) LDR SP,[Rn],#imm
- 2) LDR SP,[Rn,#imm]!
- 3) LDR SP,[Rn,#imm]
- 4) LDR SP,[Rn]
- 5) LDR SP,[Rn,Rm]

The affected instructions that can result in the stack-pointer being loaded from an incorrect memory address are:

- 1) LDR SP,[Rn],#imm
- 2) LDR SP,[Rn,#imm]!

Conditions:

- 1) An LDR is executed, with SP/R13 as the destination.
- 2) The address for the LDR is successfully issued to the memory system.
- 3) An interrupt is taken before the data has been returned and written to the stack-pointer.

Implications:

Unless the load is being performed to Device or Strongly-Ordered memory, there should be no implications from the repetition of the load. In the unlikely event that the load is being performed to Device or Strongly-Ordered memory, the repeated read can result in the final stack-pointer value being different than had only a single load been performed.

Interruption of the two write-back forms of the instruction can result in both the base register value and final stack-pointer value being incorrect. This can result in apparent stack corruption and subsequent unintended modification of memory.

Workaround: Most compilers are not affected by this, so a workaround is not required.

However, for hand-written assembly code to manipulate the stack, both issues may be worked around by replacing the direct load to the stack-pointer, with an intermediate load to a general-purpose register followed by a move to the stack-pointer.

If repeated reads are acceptable, then the base-update issue may be worked around by performing the stack pointer load without the base increment followed by a subsequent ADD or SUB instruction to perform the appropriate update to the base register.

e9005: Core: Store immediate overlapping exception return operation might vector to incorrect interrupt

Description: ARM Errata 838869: Store immediate overlapping exception return operation might vector to incorrect interrupt

Affects: Cortex-M4, Cortex-M4F

Fault Type: Programmer Category B Rare

Fault Status: Present in: r0p0, r0p1 Open.

The Cortex-M4 includes a write buffer that permits execution to continue while a store is waiting on the bus. Under specific timing conditions, during an exception return while this buffer is still in use by a store instruction, a late change in selection of the next interrupt to be taken might result in there being a mismatch between the interrupt acknowledged by the interrupt controller and the vector fetched by the processor.

Configurations Affected

This erratum only affects systems where writeable memory locations can exhibit more than one wait state.

Workaround: For software not using the memory protection unit, this erratum can be worked around by setting DISDEFWBUF in the Auxiliary Control Register.

In all other cases, the erratum can be avoided by ensuring a DSB occurs between the store and the BX instruction. For exception handlers written in C, this can be achieved by inserting the appropriate set of intrinsics or inline assembly just before the end of the interrupt function, for example:

ARMCC:

```
...  
__schedule_barrier();  
__asm{DSB};  
__schedule_barrier();  
}
```

GCC:

```
...  
__asm volatile ("dsb 0xf" ::: "memory");  
}
```

e6940: Core: VDIV or VSQRT instructions might not complete correctly when very short ISRs are used

Description: ARM Errata 709718: VDIV or VSQRT instructions might not complete correctly when very short ISRs are used

Affects: Cortex-M4F

Fault Type: Programmer Category B

Fault Status: Present in: r0p0, r0p1 Open.

On Cortex-M4 with FPU, the VDIV and VSQRT instructions take 14 cycles to execute. When an interrupt is taken a VDIV or VSQRT instruction is not terminated, and completes its execution while the interrupt stacking occurs. If lazy context save of floating point state is enabled then the automatic stacking of the floating point context does not occur until a floating point instruction is executed inside the interrupt service routine.

Lazy context save is enabled by default. When it is enabled, the minimum time for the first instruction in the interrupt service routine to start executing is 12 cycles. In certain timing conditions, and if there is only one or two instructions inside the interrupt service routine, then the VDIV or VSQRT instruction might not write its result to the register bank or to the FPSCR.

Workaround: A workaround is only required if the floating point unit is present and enabled. A workaround is not required if the memory system inserts one or more wait states to every stack transaction.

There are two workarounds:

- 1) Disable lazy context save of floating point state by clearing LSPEN to 0 (bit 30 of the FPCCR at address 0xE000EF34).
- 2) Ensure that every interrupt service routine contains more than 2 instructions in addition to the exception return instruction.

e9296: DDR: differential clock cross point voltage and clock pulse width specs not met by all devices

Description: Devices supporting DDR might have a clock cross point voltage higher than the published specifications for the DDR_CLK AC differential cross point voltage (Vox-ac). The pulse width high (Tddrckh) and pulse width low (Tddrckl) parameters can be out of specification causing the higher clock cross point.

Workaround: No functional issues are expected due to Vox-ac, Tddrckh, or Tddrckl being out of specification. On some device changes to the clock termination resistors might be able to bring the cross point into spec, but there is not a termination scheme that would be expected to bring cross point voltages within specification across all PVT (process, voltage, and temperature) conditions.

Fix plan: 5N96B mask set is planned to correct the cross point voltage for DDR2 and LPDDR1 modes.

e10521: DDR: In rare cases, one DDR byte lane can stop working correctly

Description: On some devices, the DDR controller read logic can get out of synchronization. When this occurs one of the DDR byte returns incorrect data for all reads. Typically the incorrect data returned is 0x00, but other values are possible.

The DDR can still be written when the control logic is in the incorrect state, and a reset of the RCR logic will restore normal operation to enable correct data to be read from the DDR again—that is, setting DDR_RCR[RST] and then clearing DDR_RCR[RST] to take the RCR logic out of reset.

For the small subset of devices that exhibit the issue, the problem occurs within a narrow temperature window. The temperature window is typically 20C or less in width, but the specific temperatures can be different from device to device.

Workaround: The incidence of failure can be decreased by setting the RCR logic to use a fixed delay for latching data instead of allowing it to automatically adjust the read data latch point using these steps:

1. Initialize the DDR controller, but before attempting to access it follow the remaining steps.

2. Check a pre-determined flash or non-volatile storage location to determine if a 32-bit RCR delay value has been stored. The specific location to use is determined based on system memory use.
 3. If there isn't an RCR delay value already stored, then follow these sub-steps:
 - 3a. Important: ensure that the processor is operating at room temperature before proceeding.
 - 3b. Wait at least 300 DDR clock cycles to ensure that the RCR has had time to calculate the delay value.
 - 3c. Read a 32-bit value from address 0x400A_E188. This is the current RCR delay value.
 - 3d. Write the current RCR delay value to the pre-determined storage location.
 4. Read the saved RCR delay value from flash/non-volatile memory.
 5. Write the saved RCR delay value to address 0x400A_E18C.
 6. Set bit 15 of the 32-bit register at address 0x400A_E184.
- Fix plan: 5N96B mask set is planned with improvements to correct this issue.

e5243: DDRMC: It is possible for data corruption to occur if the value programmed in RDLATADJ is larger than the CAS latency,

Description: If DDR_CR56[RDLATADJ] is programmed to be larger than the CAS latency of the device there is the possibility that data corruption may occur because the controller will pre-maturely issue DFI update requests.

Workaround: Do not set DDR_CR56[RDLATADJ] to a value larger than the CAS latency of the device. If a larger delay is required, set the RDLATADJ equal to the CAS latency of the device and use the DDR_CR52[RDDTENBAS] parameter to add any additional delay that is required.

e5241: DDRMC: Putting the memory into a power down mode while DDR_CR11[AREFMODE] is set can prevent the DDRMC from providing refreshes to the memory while it is powered down.

Description: The DDR_CR11[AREFMODE] parameter is used to determine when a refresh command is issued to the memory. The refresh command can either be issued at the next memory command boundary, or it can be held off and issued only at the next system command boundary. One system command may result in many memory commands, depending on how much data the system command is moving.

When the AREFMODE parameter is set, if a refresh is needed the controller will hold off this refresh until the next system command boundary. If the memory is manually placed into power down, and this happens at a memory command boundary but not at a system command boundary the logic holding off the refresh will erroneously continue to hold off the refresh for the duration of time the memory is placed in power down.

If the memory does not receive refreshes while in power down it is possible for the contents of the memory to degrade and become corrupted.

This condition can only occur if the low-power mode entry is done manually. This is not an issue if you are using the LPAUTO parameter to automatically enter low-power modes.

Workaround: Always clear the DDR_CR11[AREFMODE] bit before manually entering a power-down mode. If you wish to have normal operations with the AREFMODE bit set, you can do so, but ensure that you clear it before you manually place the memory into power down. After you bring the memory out of power down you can then set the AREFMODE bit again.

e5263: DDRMC: While the memory is in a power down state, setting DDR_CR11[AREF] in an attempt to force a refresh command will cause a refresh cycle to be missed.

Description: When the DDRMC has the auto refresh mode enabled (DDR_CR11[TREFEN] = 1), it will load a counter with the value in the TREF parameter, count to zero, then issue a refresh to the memory, reload the counter and repeat this cycle. There are several events which use the count value of zero from this counter to function. If a refresh is requested via a write to the AREF parameter, the counter associated with the automatic issuance of refreshes by the DDRMC will automatically be reloaded with the value in the TREF parameter and will not be able to achieve a count of zero.

One of the key pieces of logic which monitors the refresh counter equaling zero is logic associated with bringing the memory out of a power down state to enable the controller to issue a refresh command to the memory. So if the memory is in a power down state and a refresh is requested via a method other than the automatic refresh counter reaching zero the memory will not be able to be brought out of the power down state to allow the refresh to occur. This will result in extra delay before the refresh can be issued to the memory, or will result in the memory never being refreshed while in a power down state if the automatic refresh counter is disabled.

Example

Assume the memory is in a power down state and the automatic refresh mode of the DDRMC is enabled. The counter will be loaded with the value in the TREF parameter and will begin counting down. If, when the counter reaches a value near zero (but not zero), software write to AREF parameter, the counter will be automatically reloaded with the value in the TREF parameter and will then have to count down to 0 before the controller will bring the memory out of the power down state and issue the refresh. In this case the memory will fail to receive one refresh.

Workaround: Do not use the DDR_CR11[AREF] bit to attempt a refresh command to the memory while the memory is in power down mode. Always enable the automatic refresh feature of the DDRMC (set DDR_CR11[TREFEN]) and rely on it to provide refreshes to the memory.

e4588: DMAMUX: When using PIT with "always enabled" request, DMA request does not deassert correctly

Description: The PIT module is not assigned as a stand-alone DMA request source in the DMA request mux. Instead, the PIT is used as the trigger for the DMAMUX periodic trigger mode. If you want to use one of the PIT channels for periodic DMA requests, you would use the periodic trigger mode in conjunction with one of the "always enabled" DMA requests. However, the DMA request does not assert correctly in this case.

Instead of sending a single DMA request every time the PIT expires, the first time the PIT triggers a DMA transfer the "always enabled" source will not negate its request. This results in the DMA request remaining asserted continuously after the first trigger.

Workaround: Use of the PIT to trigger DMA channels where the major loop count is greater than one is not recommended. For periodic triggering of DMA requests with major loop counts greater than one, we recommended using another timer module instead of the PIT.

If using the PIT to trigger a DMA channel where the major loop count is set to one, then in order to get the desired periodic triggering, the DMA must do the following in the interrupt service routine for the DMA_DONE interrupt:

1. Set the DMA_TCDn_CSR[DREQ] bit and configure DMAMUX_CHCFGn[ENBL] = 0
2. Then again DMAMUX_CHCFGn[ENBL] = 1, DMASREQ=channel in your DMA DONE interrupt service routine so that “always enabled” source could negate its request then DMA request could be negated.

This will allow the desired periodic triggering to function as expected.

e6933: eDMA: Possible misbehavior of a preempted channel when using continuous link mode

Description: When using continuous link mode (DMA_CR[CLM] = 1) with a high priority channel linking to itself, if the high priority channel preempts a lower priority channel on the cycle before its last read/write sequence, the counters for the preempted channel (the lower priority channel) are corrupted. When the preempted channel is restored, it runs past its “done” point instead of performing a single read/write sequence and retiring.

The preempting channel (the higher priority channel) will execute as expected.

Workaround: Disable continuous link mode (DMA_CR[CLM]=0) if a high priority channel is using minor loop channel linking to itself and preemption is enabled. The second activation of the preempting channel will experience the normal startup latency (one read/write sequence + startup) instead of the shortened latency (startup only) provided by continuous link mode.

e10066: eDMA: UART0 and UART1 peripheral requests trigger DMA twice if core clock and internal bus clock frequencies are equal

Description: The UART0 and UART1 DMA request signals are routed through a gasket that translates the signals to the internal bus clock domain before routing them to the DMA. The gasket works as intended for typical cases when the core clock is faster than the internal bus clock. For cases when the core clock and internal bus clock are the same frequency the gasket will cause the DMA request to be held too long. This results in triggering the DMA twice instead of once.

Workaround: Any of the following can be used as workarounds:

- Use the UART FIFOs with watermarks set to prevent underflows and/or overflows.
- Use a UART other than UART0 or UART1. The other UARTs are clocked by the internal bus clock so they are not impacted.
- Use the UART interrupt instead of the DMA request, then software trigger the DMA in the UART interrupt handler.
- Decrease the bus clock frequency so that the core clock is at least two times faster than the internal bus clock.

e6358: ENET: Write to Transmit Descriptor Active Register (ENET_TDAR) is ignored

Description: If the ready bit in the transmit buffer descriptor (TxBD[R]) is previously detected as not set during a prior frame transmission, then the ENET_TDAR[TDAR] bit is cleared at a later time, even if additional TxBDs were added to the ring and the ENET_TDAR[TDAR] bit is set. This results in frames not being transmitted until there is a 0-to-1 transition on ENET_TDAR[TDAR].

Workaround: Code can use the transmit frame interrupt flag (ENET_EIR[TXF]) as a method to detect whether the ENET has completed transmission and the ENET_TDAR[TDAR] has been cleared. If ENET_TDAR[TDAR] is detected as cleared when packets are queued and waiting for transmit, then a write to the TDAR bit will restart TxBD processing.

e9595: FlexCAN: Corrupted frame possible if Freeze Mode or Low Power Mode are entered during a Bus-Off state

Description: In the Flexible Controller Area Network (FlexCAN) module, if the Freeze Enable bit (FRZ) of the Module Configuration Register (MCR) is asserted and the Freeze Mode is requested by asserting the Halt bit (HALT) of the MCR register during the Bus Off state, the transmission after exiting the Bus-Off condition will be corrupted. The issue occurs only if a transmission is pending before the freeze mode request. In addition, the same issue can happen if Low-Power Mode is requested instead of Freeze Mode.

Workaround: To request a Freeze or Low Power Mode during the Bus Off state, the following procedure must be followed:

A) Procedure to enter in Freeze Mode:

1. Set the Freeze Enable bit (FRZ) in the Module Control Register (MCR).
2. Check if the Module Disable bit (MDIS) in MCR register is set. If yes, clear the MDIS bit.
3. Set the Soft Reset bit (SOFTRST) in MCR.
6. Poll the MCR register until the Soft Reset (SOFTRST) bit is cleared (timeout for software implementation is 2 CAN Bits length).
7. Poll the MCR register until the Freeze Acknowledge (FRZACK) bit is set (timeout for software implementation is 2 CAN Bits length).
7. Reconfigure the Module Control Register (MCR)
8. Reconfigure all the Interrupt Mask Registers (IMASKn).

B) Procedure to enter in Low-Power Mode:

1. Enter in Freeze Mode (execute the procedure A).
2. Request the Low-Power Mode.
3. Poll the MCR register until the Low-Power Mode Acknowledge (LPMACK) bit in MCR is set (timeout for software implementation is 2 CAN Bits length).

e5641: FlexCAN: Module does not transmit a message that is enabled to be transmitted at a specific moment during the arbitration process.

Description: FlexCAN does not transmit a message that is enabled to be transmitted in a specific moment during the arbitration process. The following conditions are necessary to have the issue.

- Only one MB is configured to be transmitted
- The write which enables the MB to be transmitted (write on Control status word) happens during a specific clock during the arbitration process.

After this arbitration process occurs, the bus goes to Idle state and no new message is received on bus.

For example:

- 1) MB13 is deactivated on RxIntermission (write 0x0 on CODE field from Control Status word) - First write on CODE
- 2) Reconfigure the ID and data fields
- 3) Enable the MB13 to be transmitted on BusIdle (write 0xC on Code field) - Second write on code
- 4) CAN bus keeps in Idle state
- 5) No write on Control status from any MB happens.

During the second write on code (step 3), the write must happen one clock before the current MB13 is to be scanned by arbitration process. In this case, it does not detect the new code (0xC) and no new arbitration is scheduled.

The problem can be detectable only if the message traffic ceases and the CAN bus enters into Idle state after the described sequence of events.

There is NO ISSUE if any of the conditions below holds:

- a) Any MB (either Tx or Rx) is reconfigured (by writing its CS field) just after the Intermission field.
- b) There is other configured MB to be transmitted
- c) A new incoming message sent by any external node starts just after the Intermission field.

Workaround: To transmit a CAN frame, the CPU must prepare a Message Buffer for transmission by executing the following standard 5 step procedure:

1. Check if the respective interrupt bit is set and clear it.
2. If the MB is active (transmission pending), write the ABORT code (0b1001) to the CODE field of the Control and Status word to request an abortion of the transmission. Wait for the corresponding IFLAG to be asserted by polling the IFLAG register or by the interrupt request if enabled by the respective IMASK. Then read back the CODE field to check if the transmission was aborted or transmitted. If backwards compatibility is desired (MCR[AEN] bit negated), just write the INACTIVE code (0b1000) to the CODE field to inactivate the MB but then the pending frame may be transmitted without notification.
3. Write the ID word.
4. Write the data bytes.
5. Write the DLC, Control and CODE fields of the Control and Status word to activate the MB.

The workaround consists of executing two extra steps:

6. Reserve the first valid mailbox as an inactive mailbox (CODE=0b1000). If RX FIFO is disabled, this mailbox must be MB0. Otherwise, the first valid mailbox can be found by using table “RX FIFO filters” on FlexCAN3 chapter.

7. Write twice INACTIVE code (0b1000) into the first valid mailbox.

Note: The first mailbox cannot be used for reception or transmission process.

e9527: FlexCAN: The transmission abort mechanism may not work properly

Description: The Flexible Controller Area Network (FlexCAN) is not able to abort a transmission frame and the abort process may remain pending in the following cases:

- a) If a pending abort request occurs while the FlexCAN is receiving a remote frame.
- b) When a frame is aborted during an overload frame after a frame reception.
- c) When an abort is requested while the FlexCAN has just started a transmission.
- d) When Freeze Mode request occurs and the FlexCAN has just started a transmission.

Workaround: Use the Mailbox Inactivation mechanism instead of the transmission abort mechanism. The Abort Enable bit (AEN) of the Module Configuration Register should be kept cleared and the abort code value “0b1001” should not be written into the CODE field of the Message Buffer Control and Status word.

e5861: FTM: FTM2 and FTM3 do not correctly enter BDM mode when a debugger connection is active

Description: The FTM modules include an FTMxCONF[BDMODE] field that can be configured to control the operation of the FTM when debugging. There is a connection error in the FTM2 and FTM3 integration that prevents those modules from detecting when debug is active. As a result these two modules will operate in normal functional mode even while debugging.

Workaround: The FTMs behave as expected during normal operation (no debugger present). The issue only impacts the ability to control the operation and stop the timers while debugging.

e4710: FTM: FTMx_PWMLOAD register does not support 8-/16-bit accesses

Description: The FTM PWM Load register should support 8-bit and 16-bit accesses. However, the FTMx_PWMLOAD[LDOK] bit is cleared automatically by FTM with these sized accesses, thus disabling the loading of the FTMx_MOD, FTMx_CNTIN, and FTMx_CnV registers.

Workaround: Always use a 32-bit write access to modify contents of the FTMx_PWMLOAD register.

e9265: FTM: Incorrect match may be generated if intermediate load feature is used in toggle mode

Description: When a channel (n) match is used as an intermediate reload, an incorrect second match may occur immediately following the correct match. The issue is problematic only if channel (n) is configured for output compare with the output configured to toggle mode. In this scenario,

channel (n) toggles on the correct match and again on the incorrect match. The issue may also occur if a certain channel has a match which is coincident with an intermediate reload point of any other channel.

Workaround: If any channel is configured for output compare mode with the output set for toggle mode, the intermediate reload feature must not be used.

e6484: FTM: The process of clearing the FTMx_SC[TOF] bit does not work as expected under a certain condition when the FTM counter reaches FTM_MOD value.

Description: The process of clearing the TOF bit does not work as expected when FTMx_CONF[NUMTOF] != 0 and the current TOF count is less than FTMx_CONF[NUMTOF], if the FTM counter reaches the FTM_MOD value between the reading of the TOF bit and the writing of 0 to the TOF bit. If the above condition is met, the TOF bit remains set, and if the TOF interrupt is enabled (FTMx_SC[TOIE] = 1), the TOF interrupt also remains asserted.

Workaround: Two possible workarounds exist for this erratum and the decision on which one to use is based on the requirements of your particular application.

1) Repeat the clearing sequence mechanism until the TOF bit is cleared.

Below is a pseudo-code snippet that would need to be included in the TOF interrupt routine.

```
while (FTM_SC[TOF]!=0) { void FTM_SC(); // Read SC register FTM_SC[TOF]=0 ; // Write 0 to TOF bit }
```

2) With FTMx_CONF[TOFNUM] = 0 and a variable in the software, count the number of times that the TOF bit is set. In the TOF interrupt routine, clear the TOF bit and increment the variable that counts the number of times that the TOF bit was set.

e9004: ITM can deadlock when global timestamping is enabled

Description: The Cortex-M4 processor contains an optional Instrumentation Trace Macrocell (ITM). This can be used to generate trace data under software control, and is also used with the Data Watchpoint and Trace (DWT) module which generates event driven trace. The processor supports global timestamping. This allows count values from a system-wide counter to be included in the trace stream.

When connected directly to a CoreSight funnel (or other component which holds ATREADY low in the idle state), the ITM will stop presenting trace data to the ATB bus after generating a timestamp packet. In this condition, the ITM_TCR.BUSY register will indicate BUSY.

Once this condition occurs, a reset of the Cortex-M4 is necessary before new trace data can be generated by the ITM.

Timestamp packets which require a 5 byte GTS1 packet, or a GTS2 packet do not trigger this erratum. This generally only applies to the first timestamp which is generated.

Devices which use the Cortex-M optimized TPIU (CoreSight ID register values 0x923 and 0x9A1) are not affected by this erratum.

Workaround: There is no software workaround for this erratum. If the device being used is susceptible to this erratum, you must not enable global timestamping.

e6573: JTAG: JTAG TDO function on the PTA2 disables the pull resistor

Description: The JTAG TDO function on the PTA2 pin disables the pull resistor, but keeps the input buffer enabled. Because the JTAG will tri-state this pin during JTAG reset (or other conditions), this pin will float with the input buffer enabled. If the pin is unconnected in the circuit, there can be increased power consumption in low power modes for some devices.

Workaround: Disable JTAG TDO functionality when the JTAG interface is not needed and left floating in a circuit. Modify the PORTA_PCR2 mux before entering low power modes. Set the mux to a pin function other than ALT7. If set up as a digital input and left unconnected in the circuit, then a pull-up or pull-down should be enabled. Alternatively, an external pull device or external source can be added to the pin.

Note: Enabling the pull resistor on the JTAG TDO function violates the JTAG specification.

e4553: LCDC: Cursor Color Limited in 24bpp Mode

Description: The LCCMR register which determines the cursor color has a maximum of 6 bits per color (18bpp). Thus when trying to use the cursor in 24bpp mode, the first two bits of each 8-bit cursor color sent to the LCD are zero.

Workaround: The least significant 6 bits of each color can be used for the cursor color in 24bpp mode.

e4569: LCDC: Graphic Window Color Key Limited in 24bpp Mode

Description: The GWCKR, GWCKG, and GWCKB fields in the LGWCR register determine which color in the graphic window is transparent. These fields are each 6 bits in length (18bpp). This limits the colors that can be used for the color key in 24bpp mode.

Workaround: In 24bpp mode, the color that is being keyed out must have the first two bits be zero for the comparison to work. The lower 6 bits will be compared as usual.

e4570: LCDC: Graphic Window May Shift Pixel Data

Description: When a graphic window is located at location (0,0) or (1,0), the data output to the LCD in the graphic window will be shifted over by one pixel.

This means that the first piece of pixel data in your frame buffer will be the second pixel sent out instead of the first pixel as expected. Then the second piece of data will be the third pixel sent out, and so on. This continues throughout the buffer, so that the first pixel of the graphic window display will come from the very end of the frame buffer data instead of from the very front.

The end result is a pixel-wide line of data that should be on the far right of the graphic window is instead displayed on the far left of the graphic window. The data displayed in the graphic window is also one pixel further to the right than it should be.

Workaround: Ensure your graphic window is not located at either (0,0) or (1,0) or account for this shift in the data being used for the graphic window.

e4571: LCDC: LCDC can only use half of internal SRAM for frame buffer

Description: The LCDC background plane or graphic window requires that its frame buffer be within a 4MB boundary, as address A[31:22] has a fixed value for a picture's image. As the LCDC tries to read data from the internal SRAM, it will loop back to the start of that 4MB boundary, and into invalid memory space, upon reaching address 0x2000_0000.

Thus only half of the available SRAM is available for a frame buffer instead of the entire SRAM.

Workaround: Use the background plane to display data located in the first half of the SRAM, and place the image in RAM so that it will be at the end of a line when it reaches location 0x1FFF_FFFF.

Then use the graphic window to display the data from the other half of SRAM starting at 0x2000_0000, taking care to place the graphic window so as to line up seamlessly with the end of the background plane.

e8010: LLWU: CMP flag in LLWU_Fx register cleared by multiple CMP out toggles when exiting LLSx or VLLSx modes.

Description: The comparator's corresponding wakeup flag in the LLWU_Fx register is cleared prematurely if:

1. The CMP output is toggled more than one time during the LLSx wakeup sequence and the comparator's corresponding flag in the LLWU_Fx register is cleared.

Or

2. The CMP output is toggled more than one time during the VLLSx wakeup sequence, PMC_REGSC[ACKISO] is cleared, and the comparator's corresponding flag in the LLWU_Fx register is cleared.

Workaround: When MCU is waking up from LLS, code can implement a software flag to retain the wakeup source, if required by software.

When MCU is waking up from VLLSx, code can implement a software flag prior to clearing PMC_REGSC[ACKISO] to retain the wakeup source, if required by software.

e7993: MCG: FLL frequency may be incorrect after changing the FLL reference clock

Description: When the FLL reference clock is switched between the internal reference clock and the external reference clock, the FLL may jump momentarily or lock at a higher than configured frequency. The higher FLL frequency can affect any peripheral using the FLL clock as its input clock. If the FLL is being used as the system clock source, FLL Engaged Internal (FEI) or FLL Engaged External (FEE), the maximum system clock frequency may be exceeded and can cause indeterminate behavior.

Only transitions from FLL External reference (FBE, FEE) to FLL Internal reference (FBI, FEI) modes and vice versa are affected. Transitions to and from BLPI, BLPE, or PLL clock modes (if supported) are not affected because they disable the FLL. Transitions between the external reference modes or between the internal reference modes are not affected because the reference clock is not changed.

Workaround: To prevent the occurrence of this jump in frequency either the MCG_C4[DMX32] bit must be inverted or the MCG_C4[DRST_DRS] bits must be modified to a different value immediately before the change in reference clock is made and then restored back to their original value after the MCG_S[IREFST] bit reflects the selected reference clock.

If you want to change the MCG_C4[DMX32] or MCG_C4[DRST_DRS] to new values along with the reference clock, the sequence described above must be performed before setting these values to the new value(s).

e7735: MCG: IREFST status bit may set before the IREFS multiplexor switches the FLL reference clock

Description: When transitioning from MCG clock modes FBE or FEE to either FBI or FEI, the MCG_S[IREFST] bit will set to 1 before the IREFS clock multiplexor has actually selected the slow IRC as the reference clock. The delay before the multiplexor actually switches is:

2 cycles of the slow IRC + 2 cycles of OSCERCLK

In the majority of cases this has no effect on the operation of the device.

Workaround: In the majority of applications no workaround is required. If there is a requirement to know when the IREFS clock multiplexor has actually switched, and OSCERCLK is no longer being used by the FLL, then wait the equivalent time of:

2 cycles of the slow IRC + 2 cycles of OSCERCLK

after MCG_S[IREFST] has been set to 1.

e3898: MCG: Setting the MCG_C6[PLLS] bit will enable both OSC0 and OSC1.

Description: When the PLL is enabled by means of setting the MCG_C6[PLLS] bit, both OSC0 and OSC1 will be enabled. This will only occur when moving the MCG to PBE, BLPE or PEE modes.

Workaround: If an oscillator is not being used and PBE, BLPE or PEE modes are to be used, ensure that the IREFS bit associated with the unused oscillator is cleared. The IO pins associated with that oscillator should also be configured as GPIO outputs driving a logic 0. This will place the IO pads in a consistent state and keep excess current consumption to a minimum level.

e4590: MCG: Transitioning from VLPS to VLPR low power modes while in BLPI clock mode is not supported.

Description: Transitioning from VLPS mode back to VLPR (LPWUI control bit = 0) while using BLPI clock mode only, is not supported. During Fast IRC startup, the output clock frequency may exceed the maximum VLPR operating frequency. This does not apply to the BLPE clock mode.

Workaround: There are two options for workarounds

a) Exit to Run instead of VLPR. Before entering VLPR set the LPWUI bit so that when exiting VLPS mode the MCU exits to RUN mode instead of VLPR mode. With LPWUI set any interrupt will exit VLPR or VLPS back into RUN mode. To minimize the impact of the higher RUN current re-enter VLPR quickly.

or

b) Utilize MCG clock mode BLPE when transitioning from VLPS to VLPR modes.

e4176: NMI: NMI interrupt service routine (ISR) might not be called when MCU wakes up from VLLSx modes.

Description: When MCU wakes up from VLLSx modes via NMI pin the NMI ISR might not be called if the NMI pulse width is lower than 120us..

Workaround: NMI pulse width must be asserted for at least 120usec to ensure NMI ISR is called and entered. Note that a short NMI pulse will still wakeup the part, and the LLWU ISR will still be entered.

e3794: NVIC: NMI interrupt does not wakeup MCU from STOP and VLPS

Description: NMI interrupt does not wakeup MCU from STOP and VLPS when the bits CSYSPWRUPREQ and CDBGPWRUPREQ in the Control/Status Register of the DAP Port are cleared.

Workaround: If a debugger connection is established, the CSYSPWRUPREQ and CDBGPWRUPREQ bits are set by default, so an NMI interrupt will wake up the MCU from STOP and VLPS modes. In the absence of a debug connection and after a POR event, the bits will be cleared and thus an NMI interrupt will not wake the MCU.

e5927: Operating requirements: Change to minimum VDD spec

Description: The minimum operating voltage for VDD is 2.0V.

Workaround: Ensure that VDD is 2.0V or higher. Keep in mind that if VDD_DDR is used, that VDD must also be higher than VDD_DDR as per the original specification.

e9697: PMC: Possible power on resets when VDDINT and VDD are not at the same voltage

Description: When VDDINT and VDD are not at the same voltages such as when VDDINT = 1.8V and VDD = 3.3 V, transitioning from any low power mode to VLPR or RUN modes can cause spurious power on resets (POR/LVD).

Workaround: 1) Stay in RUN or VLPR, not switching between low power mode and RUN or VLPR mode.
2) Make VDDINT and VDD voltages the same (VDD's all tied together)

e5667: PMC: When used as an input to ADC or CMP modules, the PMC bandgap 1-V voltage reference is not available in VLPx, LLS, or VLLSx modes

Description: The Power Management Controller (PMC) bandgap 1-V reference is not available as an input to the Analog-to-Digital Converter (ADC) module (using ADC input channel AD27) or the Comparator (CMP) module (using CMP input IN6) in Very Low Power Run (VLPR), Very Low

Power Wait (VLPW), Very Low Power Stop (VLPS), Low Leakage Stop (LLS), Very Low Leakage Stop3 (VLLS3), Very Low Leakage Stop2 (VLLS2), Very Low Leakage Stop1 (VLLS1), or Very Low Leakage Stop0 (VLLS0) modes.

This erratum does not apply to the VREF module 1.2 V reference voltage.

Workaround: Use of the PMC bandgap 1-V reference voltage as an input to the ADC and CMP modules requires the MCU to be in Run, Wait, or Stop modes.

e9293: PORT: Internal pull resistors not enabled for all pin functions

Description: The PORTx_PCRn registers contain pull enable (PE) and pull select (PS) bits that can be used to enable an internal pullup or pulldown resistor on each pin. The pull resistor is intended to be active for any selected digital function when enabled, however, for certain digital output signals the internal pull resistor is not enabled even when the pin function is not actively driving the pin.

The pin functions impacted are:

FB_An (dedicated address lines only, AD functions are not impacted)

FB_R/W

SPIx_PCSn

SPIx_SOUT

I2Sx_TXD[1:0]

CMPx_OUT

Note: The internal pull resistor is not enabled when the JTAG_TDO function is selected on a pin. This is intentional because the JTAG_TDO pin must not have a pullup.

Workaround: The workaround depends on the which pin function is used.

For FlexBus signals, the pins will float any time there is not a FlexBus cycle in progress. External pull resistors should be used on the FB_An and FB_R/W pins to avoid floating pin conditions.

For SPI signals, the SPI module must be initialized including selected master or slave mode before the SPI functions are enabled in the PORTx_PCRn registers. After the SPI module is enabled as a master, the SPI chip select signals will be actively driven.

For I2S signals, the I2S module must be initialized before the PORTx_PCRn registers are configured to select the I2S functions.

For comparator signals, the comparator module must be initialized including setting the OPE and EN bits in the CMPx_CR1 register before configuring the PORTx_PCRn registers to enable comparator functions.

The workarounds above are intended to eliminate floating conditions for the affected pin functions. As an alternative, external pull resistors could be used for any of the modules listed above to ensure that signals do not float.

e5130: SAI: Under certain conditions, the CPU cannot reenter STOP mode via an asynchronous interrupt wakeup event

Description: If the SAI generates an asynchronous interrupt to wake the core and it attempts to reenter STOP mode, then under certain conditions the STOP mode entry is blocked and the asynchronous interrupt will remain set.

This issue applies to interrupt wakeups due to the FIFO request flags or FIFO warning flags and then only if the time between the STOP mode exit and subsequent STOP mode reentry is less than 3 asynchronous bit clock cycles.

Workaround: Ensure that at least 3 bit clock cycles elapse following an asynchronous interrupt wakeup event, before STOP mode is reentered.

e3981: SDHC: ADMA fails when data length in the last descriptor is less or equal to 4 bytes

Description: A possible data corruption or incorrect bus transactions on the internal AHB bus, causing possible system corruption or a stall, can occur under the combination of the following conditions:

1. ADMA2 or ADMA1 type descriptor
2. TRANS descriptor with END flag
3. Data length is less than or equal to 4 bytes (the length field of the corresponding descriptor is set to 1, 2, 3, or 4) and the ADMA transfers one 32-bit word on the bus
4. Block Count Enable mode

Workaround: The software should avoid setting ADMA type last descriptor (TRANS descriptor with END flag) to data length less than or equal to 4 bytes. In ADMA1 mode, if needed, a last NOP descriptor can be appended to the descriptors list. In ADMA2 mode this workaround is not feasible due to ERR003983.

e3982: SDHC: ADMA transfer error when the block size is not a multiple of four

Description: Issue in eSDHC ADMA mode operation. The eSDHC read transfer is not completed when block size is not a multiple of 4 in transfer mode ADMA1 or ADMA2. The eSDHC DMA controller is stuck waiting for the IRQSTAT[TC] bit in the interrupt status register.

The following examples trigger this issue:

1. Working with an SD card while setting ADMA1 mode in the eSDHC
2. Performing partial block read
3. Writing one block of length 0x200
4. Reading two blocks of length 0x22 each. Reading from the address where the write operation is performed. Start address is 0x512 aligned. Watermark is set as one word during read. This read is performed using only one ADMA1 descriptor in which the total size of the transfer is programmed as 0x44 (2 blocks of 0x22).

Workaround: When the ADMA1 or ADMA2 mode is used and the block size is not a multiple of 4, the block size should be rounded to the next multiple of 4 bytes via software. In case of write, the software should add the corresponding number of bytes at each block end, before the write is initialized. In case of read, the software should remove the dummy bytes after the read is completed.

For example, if the original block length is 22 bytes, and there are several blocks to transfer, the software should set the block size to 24. The following data is written/stored in the external memory:

4 Bytes valid data
4 Bytes valid data
4 Bytes valid data
4 Bytes valid data
4 Bytes valid data
2 Bytes valid data + 2 Byte dummy data
4 Bytes valid data
4 Bytes valid data
4 Bytes valid data
4 Bytes valid data
4 Bytes valid data
2 Bytes valid data + 2 Byte dummy data

In this example, 48 (24 × 2) bytes are transferred instead of 44 bytes. The software should remove the dummy data.

e4624: SDHC: AutoCMD12 and R1b polling problem

Description: Occurs when a pending command which issues busy is completed. For a command with R1b response, the proper software sequence is to poll the DLA for R1b commands to determine busy state completion. The DLA polling is not working properly for the ESDHC module and thus the DLA bit in PRSSTAT register cannot be polled to wait for busy state completion. This is relevant for all eSDHC ports (eSDHC1-4 ports).

Workaround: Poll bit 24 in PRSSTAT register (DLSL[0] bit) to check that wait busy state is over.

e3977: SDHC: Does not support Infinite Block Transfer Mode

Description: The eSDHC does not support infinite data transfers, if the Block Count register is set to one, even when block count enable is not set.

Workaround: The following software workaround can be used instead of the infinite block mode:

1. Set BCEN bit to one and enable block count
2. Set the BLKCNT to the maximum value in Block Attributes Register (BLKATTR) (0xFFFF for 65535 blocks)

e4627: SDHC: Erroneous CMD CRC error and CMD Index error may occur on sending new CMD during data transfer

Description: When sending new, non data CMD during data transfer between the eSDHC and EMMC card, the module may return an erroneous CMD CRC error and CMD Index error. This occurs when the CMD response has arrived at the moment the FIFO clock is stopped. The following bits after the start bit of the response are wrongly interpreted as index, generating the CRC and Index errors.

The data transfer itself is not impacted.

The rate of occurrence of the issue is very small, as there is a need for the following combination of conditions to occur at the same cycle:

- The FIFO clock is stopped due to FIFO full or FIFO empty
- The CMD response start bit is received

Workaround: The recommendation is to not set FIFO watermark level to a too small value in order to reduce frequency of clock pauses.

The problem is identified by receiving the CMD CRC error and CMD Index error. Once this issue occurs, one can send the same CMD again until operation is successful.

e3984: SDHC: eSDHC misses SDIO interrupt when CINT is disabled

Description: An issue is identified when interfacing the SDIO card. There is a case where an SDIO interrupt from the card is not recognized by the hardware, resulting in a hang.

If the SDIO card lowers the DAT1 line (which indicates an interrupt) when the SDIO interrupt is disabled in the eSDHC registers (that is, CINTEN bits in IRQSTATEN and IRQSIGEN are set to zero), then, after the SDIO interrupt is enabled (by setting the CINTEN bits in IRQSTATEN and IRQSIGEN registers), the eSDHC does not sense that the DAT1 line is low. Therefore, it fails to set the CINT interrupt in IRQSTAT even if DAT1 is low.

Generally, CINTEN bit is disabled in interrupt service.

The SDIO interrupt service steps are as follows:

1. Clear CINTEN bit in IRQSTATEN and IRQSIGEN.
2. Reset the interrupt factors in the SDIO card and write 1 to clear the CINT interrupt in IRQSTAT.
3. Re-enable CINTEN bit in IRQSTATEN and IRQSIGEN.

If a new SDIO interrupt from the card occurs between step 2 and step 3, the eSDHC skips it.

Workaround: The workaround interrupt service steps are as follows:

1. Clear CINTEN bit in IRQSTATEN and IRQSIGEN.
2. Reset the interrupt factors in the SDIO card and write 1 to clear CINT interrupt in IRQSTAT.
3. Clear and then set D3CD bit in the PROCTL register. Clearing D3CD bit sets the reverse signal of DAT1 to low, even if DAT1 is low. After D3CD bit is re-enabled, the eSDHC can catch the posedge of the reversed DAT1 signal, if the DAT1 line is still low.
4. Re-enable CINTEN bit in IRQSTATEN and IRQSIGEN.

e3980: SDHC: Glitch is generated on card clock with software reset or clock divider change

Description: A glitch may occur on the SDHC card clock when the software sets the RSTA bit (software reset) in the system control register. It can also be generated by setting the clock divider value. The glitch produced can cause the external card to switch to an unknown state. The occurrence is not deterministic.

Workaround: A simple workaround is to disable the SD card clock before the software reset, and enable it when the module resumes the normal operation. The Host and the SD card are in a master-slave relationship. The Host provides clock and control transfer across the interface. Therefore, any existing operation is discarded when the Host controller is reset.

The recommended flow is as follows:

1. Software disable bit[3], SDCLKEN, of the System Control Register
2. Trigger software reset and/or set clock divider
3. Check bit[3], SDSTB, of the Present State Register for stable clock
4. Enable bit[3], SDCLKEN, of the System Control Register.

Using the above method, the eSDHC cannot send command or transfer data when there is a glitch in the clock line, and the glitch does not cause any issue.

e6934: SDHC: Issues with card removal/insertion detection

Description: SD cards include a 50K pullup that is used to detect when a card is inserted. A weak (500K) pulldown on the line is sufficient to allow for the first card insertion to be detected (the 50K pullup on the card will dominate the pulldown and cause the signal to go high).

The 5 V tolerant I/O cells used on this processor require a pulldown resistor stronger than 50K to ensure that a signal will reach a proper low voltage level after the pin has been high. A stronger pulldown cannot be used on the SD card detect signal because it would prevent the card detection from working correctly. Because of this, the automatic card removal detection will not work reliably.

Workaround: A software workaround can be used to check for card removal or verify that a card is still present by redetecting it.

1. Temporarily change the appropriate PORTx_PCRn to configure the SD card detect pin as a GPIO.
2. Configure the GPIO as an output driving low.
3. Leave the pin in this state for several us. The exact amount of time required can vary depending on pin loading.
4. Change the PORTx_PCRn to switch the pin back to its SDHC function.

When this sequence is complete the SDHC will be ready to detect card insertion again. The sequence above should be run periodically or if an unexpected response is received from the SD card. The procedure will discharge the I/O cell so that the card detect pin is low and an SD card (if present) can be detected.

e3983: SDHC: Problem when ADMA2 last descriptor is LINK or NOP

Description: ADMA2 mode in the eSDHC is used for transfers to/from the SD card. There are three types of ADMA2 descriptors: TRANS, LINK or NOP. The eSDHC has a problem when the last descriptor (which has the End bit '1') is a LINK descriptor or a NOP descriptor.

In this case, the eSDHC completes the transfers associated with this descriptor set, whereas it does not even start the transfers associated with the new data command. For example, if a WRITE transfer operation is performed on the card using ADMA2, and the last descriptor of the WRITE descriptor set is a LINK descriptor, then the WRITE is successfully finished. Now, if a READ transfer is programmed from the SD card using ADMA2, then this transfer does not go through.

Workaround: Software workaround is to always program TRANS descriptor as the last descriptor.

e3978: SDHC: Software can not clear DMA interrupt status bit after read operation

Description: After DMA read operation, if the SDHC System Clock is automatically gated off, the DINT status can not be cleared by software.

Workaround: Set HCKEN bit before starting DMA read operation, to disable SDHC System Clock auto-gating feature; after the DINT and TC bit received when read operation is done, clear HCKEN bit to re-enable the SDHC System Clock auto-gating feature.

e3941: SIM/DDR: SIM_SOPT2[FBSL] does not determine allowable DDR controller accesses when security is enabled

Description: On devices that include a DDR controller, the SIM_SOPT2[FBSL] field should determine what FlexBus and DDR accesses are allowed when the device is secure, but currently the FBSL field only controls the allowable FlexBus accesses.

Workaround: Until the feature is corrected customers should be aware that DDR could be used to execute code even when the device is secure. Some applications might want to avoid using DDR when secure and/or use the MPU to restrict the DDR to supervisor access only.

e4218: SIM/FLEXBUS: SIM_SCGC7[FLEXBUS] bit should be cleared when the FlexBus is not being used.

Description: The SIM_SCGC7[FLEXBUS] bit is set by default. This means that the FlexBus will be enabled and come up in global chip select mode.

With some code sequence and register value combinations the core could attempt to prefetch from the FlexBus even though it might not actually use the value it prefetched. In the case where the FlexBus is unconfigured, this can result in a hung bus cycle on the FlexBus.

Workaround: If the FlexBus is not being used, disabled the clock to the FlexBus during chip initialization by clearing the SIM_SCGC7[FLEXBUS] bit.

If the FlexBus will be used, then enable at least one chip select as early in the chip initialization process as possible.

e5952: SMC: Wakeup via the LLWU from LLS/VLLS to RUN to VLPR incorrectly triggers an immediate wakeup from the next low power mode entry

Description: Entering VLPR immediately after an LLWU wakeup event from LLS/VLLS, will cause any subsequent entry into LLS/VLLS to fail if entry into VLPR mode occurs before clearing the pending LLWU interrupt.

Workaround: After an LLWU wakeup event from LLS/VLLS, the user must clear the LLWU interrupt prior to entering VLPR mode.

e7166: SOC: SDHC, NFC, USBOTG, and cache modules are not clocked correctly in low-power modes

Description: The SDHC, NFC, and USBOTG are connected to a single master port on the crossbar switch through a multiplexer. The modules themselves are still clocked in Wait mode, but the multiplexer connecting them to the crossbar switch has its clock shut off immediately during entry into low-power modes. This prevents these three modules from completing bus transactions during any low-power mode entry or starting new bus transactions when the system enters Wait mode (even though the modules themselves remain clocked in Wait).

In addition the cache tag and data RAMs have their clock gated off in Wait mode. This can lead to corruption of cache contents during low-power entry.

Workaround: To resolve the low-power mode entry issue with the SDHC, NFC, and USBOTG, software should ensure that all bus master operations for these three modules are complete before requesting the system entry into any of the low-power modes. In addition, no bus traffic from these modules should be generated while the system is in Wait.

To avoid cache corruption during low-power mode entry, the following code sequence should be used for entry into low-power modes when the cache is enabled:

```
/* The LMEM writes below will perform NOP operations on both of the caches */
LMEM_PCCLCR = 0x09000001;
LMEM_PSCLCR = 0x09000001;
/* Wait for cache command to complete */
While (LMEM_PCCLCR & 1);
/* Wait for cache command to complete */
While (LMEM_PSCLCR & 1);
Asm("DSB");
Asm("WFI");
Asm("NOP");
Asm("NOP");
Asm("NOP");
Asm("NOP");
Asm("NOP");
Asm("NOP");
```

Asm("NOP");

Asm("NOP");

Asm("NOP");

The code sequence above must be executed from a memory location that is not cached (SRAM_L is recommended). In addition, the start of the code sequence through the WFI must execute uninterrupted. If an interrupt occurs between the start of the sequence and the WFI instruction, then the code sequence must be restarted from the beginning. The NOPs in the sequence can be replaced with other code if desired, as long as that code doesn't make reference to any cached addresses.

e9682: SPI: Inconsistent loading of shift register data into the receive FIFO following an overflow event

Description: In the Serial Peripheral Interface (SPI) module, when both the receive FIFO and shift register are full (Receive FIFO Overflow Flag bit in Status Register is set (SR [RFOF] = 0b1)) and then the Clear Rx FIFO bit in Module Configuration Register (MCR [CLR_RXF]) is asserted to clear the receive FIFO, shift register data is loaded into the receive FIFO after the clear operation completes.

Workaround: 1. Avoid a receive FIFO overflow condition (SR[RFOF] should never be 0b1). To do this, monitor the RX FIFO Counter field of the Status Register (SR[RXCTR]) which indicates the number of entries in receive FIFO and clear before the counter equals the FIFO depth.

2. Alternatively, after every receive FIFO clear operation (MCR[CLR_RXF] = 0b1) following a receive FIFO overflow (SR[RFOF] = 0b1) scenario, perform a single read from receive FIFO and discard the read data.

e2638: TSI: The counter registers are not immediately updated after the EOSF bit is set.

Description: The counter registers are not immediately updated after the end of scan event (EOSF is set). The counter registers will become available 0.25 ms after the EOSF flag is set. This also applies for the end-of-scan interrupt, as it is triggered with the EOSF flag. This behavior will occur both in continuous scan and in software triggered scan modes.

Workaround: Insert a delay of 0.25 ms or greater prior to accessing the counter registers after an end of scan event or an end of scan interrupt that is triggered by the EOSF flag. This delay does not need to be a blocking delay, so it can be executing other actions before reading the counter registers. Notice that the out-of-range flag (OUTRGF) and interrupt occur after the counters have been updated, so if the OUTRGF flag is polled or the out-of-range interrupt is used, the workaround is not necessary.

e4546: TSI: The counter values reported from TSI increase when in low power modes (LLS, VLLS1, VLLS2, VLLS3)

Description: When the MCU goes into LLS or VLLSx modes, with the TSI enabled for wakeup, the counter value reported by the TSI increases with respect to what was reported in active mode. Because the wakeup threshold is calculated in active mode, it is highly likely that MCU will wakeup immediately after going to low power.

Workaround: 1. Use Wait, Stop, or VLPS. These modes do not require any wakeup threshold calibration as TSI remains in active mode and wakes up each end of scan so that normal baseline tracking algorithm can be used.

2. To use LLS or VLLSx modes with the TSI as a wakeup source, calibrate the wakeup threshold using the desired low power mode. During application initialization, configure the TSI to exit low power via the LLWUI (low-leakage wake-up interrupt) with an End of Scan using the desired wakeup electrode. For example enter LLS mode with automatic scanning enabled so that after the first scan the TSI module causes an exit from low power at the end of scan. After the wakeup event, read the TSIx_WUCNTR Register, this register will have the value for the count during low power mode. Use this value to calculate THRS_HLD register value.

e3926: TSI: The TSI will run several scan cycles during reference clock instead of scanning each electrode once

Description: The TSI will run several scan cycles during reference clock instead of scanning each electrode once. For each automatic scanning period determined by AMCLKS (clock source), AMPSC (prescaler) and SMOD (period modulo), TSI will scan during one reference clock cycle divided by the AMPSC prescaler.

This does not affect the count result from TSI because TSI counters keep the last scan result.

Workaround: 1. Because counter results are not affected, a simple workaround is to use the smallest prescaler possible and use a bigger SMOD value, this will minimize the number of extra scans, thus also minimizing the amount of average extra current used by the module.

2. If strict control of number of scan cycles is needed, trigger scans with software control (using the SWTS bit) and control time between scans with a separate timer. This solution is only recommended if strict control of scan cycles is needed, if not, recommendation is to use workaround 1.

e4181: TSI: When the overrun flag is set, the TSI scanning sequence will exhibit undefined behavior.

Description: When the overrun flag is set, the TSI scanning sequence will exhibit undefined behavior, so the results of measurements are invalid at this point. In order to continue reading valid measurements, disable the TSI module and reconfigure it.

Workaround: During development make sure to measure the required scanning time for all the electrodes in your system and configure the scanning time with AMCLKS, AMPSC and SMOD so that an overrun will not happen. Consider adding about 30 to 70% more time as headroom to make sure overrun is not triggered. If scanning time is critical and added scan time is not acceptable, detect the overrun condition either by polling the overrun flag in a loop or through the TSI interrupt. Once overrun is detected, disable the TSI module, clear all flags and reconfigure. During reconfiguration, SMOD can be increased by 10% or more of the current value to reduce the number of overrun occurrences.

e4935: UART: CEA709.1 features not supported

Description: Due to some issues that affect compliance with the specification, the CEA709.1 features of the UART module are not supported. Normal UART mode, IrDA, and ISO-7816 are unaffected.

Workaround: Do not use the UART in CEA709.1 mode.

e7028: UART: During ISO-7816 initial character detection the parity, framing, and noise error flags can set

Description: When performing initial character detection (UART_C7816[INIT] = 1) in ISO-7816 mode the UART should not set error flags for any receive traffic before a valid initial character is detected, but the UART will still set these error flags if any of the conditions are true.

Workaround: After a valid initial character is detected (UART_IS7816[INITD] sets), check the UART_S1[NF, FE, and PF] flags. If any of them are set, then clear them.

e7027: UART: During ISO-7816 T=0 initial character detection invalid initial characters are stored in the Rx FIFO

Description: When performing initial character detection (UART_C7816[INIT] = 1) in ISO-7816 T=0 mode with UART_C7816[ANACK] cleared, the UART samples incoming traffic looking for a valid initial character. Instead of discarding any invalid initial characters that are received, the UART will store them in the receive FIFO.

Workaround: After a valid initial character is detected (UART_IS7816[INITD] sets), flush the Rx FIFO to discard any invalid initial characters that might have been received before the valid initial character.

e8184: UART: During ISO-7816 T=0, TC bit set at 12 ETUs may cause loss of characters when UART is switched from transmit to receive mode

Description: In ISO-7816 T=0 mode, if S1[TC] is set at 12 ETUs to indicate end of transmission and software then switches the UART to receive mode by setting C2[RE], the first received character may be lost.

Workaround: For EMV card applications, no workaround is required since the maximum turnaround time for EMV-compliant cards is 15 ETUs, per the EMV L1 test specification (1CF.004.00).
No workaround is available for ISO-7816-compliant cards.

e6472: UART: ETU compensation needed for ISO-7816 wait time (WT) and block wait time (BWT)

Description: When using the default ISO-7816 values for wait time integer (UARTx_WP7816T0[WI]), guard time FD multiplier (UARTx_WF7816[GTFD]), and block wait time integer (UARTx_WP7816T1[BWI]), the calculated values for Wait Time (WT) and Block Wait Time (BWT) as defined in the Reference Manual will be 1 ETU less than the ISO-7816-3 requirement.

Workaround: To comply with ISO-7816 requirements, compensation for the extra 1 ETU is needed. This compensation can be achieved by using a timer, such as the low-power timer (LPTMR), to introduce a 1 ETU delay after the WT or BWT expires.

e4647: UART: Flow control timing issue can result in loss of characters if FIFO is not enabled

Description: On UARTx modules with FIFO depths greater than 1, when the /RTS flow control signal is used in receiver request-to-send mode, the /RTS signal is negated if the number of characters in the Receive FIFO is equal to or greater than the receive watermark. The /RTS signal will not negate until after the last character (the one that makes the condition for /RTS negation true) is completely received and recognized. This creates a delay between the end of the STOP bit and the negation of the /RTS signal. In some cases this delay can be long enough that a transmitter will start transmission of another character before it has a chance to recognize the negation of the /RTS signal (the /CTS input to the transmitter).

Workaround: Always enable the RxFIFO if you are using flow control for UARTx modules with FIFO depths greater than 1. The receive watermark should be set to seven or less. This will ensure that there is space for at least one more character in the FIFO when /RTS negates. So in this case no data would be lost.

Note that only UARTx modules with FIFO depths greater than 1 are affected. The UARTs that do not have the RxFIFO feature are not affected. Check the Reference Manual for your device to determine the FIFO depths that are implemented on the UARTx modules for your device.

e7090: UART: In ISO-7816 mode, timer interrupts flags do not clear

Description: In ISO-7816, when any of the timer counter expires, the corresponding interrupt status register bits gets set. The timer register bits cannot be cleared by software without additional steps, because the counter expired signal remains asserted internally. Therefore, these bits can be cleared only after forcing the counters to reload.

Workaround: Follow these steps to clear the UART_IS7816 WT, CWT, or BWT bits:

1. Clear the UART_C7816[ISO_7816E] bit, to temporarily disable ISO-7816 mode.
2. Write 1 to the WT, CWT, or BWT bits that need to be cleared.
3. Set UART_C7816[ISO_7816E] to re-enable ISO-7816 mode.

Note that the timers will start counting again as soon as the ISO_7816E bit is set. To avoid unwanted timeouts, software might need to wait until new transmit or receive traffic is expected or desired before re-enabling ISO-7816 mode.

e7029: UART: In ISO-7816 T=1 mode, CWT interrupts assert at both character and block boundaries

Description: When operating in ISO-7816 T=1 mode and switching from transmission to reception block, the character wait time interrupt flag (UART_IS7816[CWT]) should not be set, only block type interrupts should be valid. However, the UART can set the CWT flag while switching from transmit to receive block and at the start of transmit blocks.

Workaround: If a CWT interrupt is detected at a block boundary instead of a character boundary, then the interrupt flag should be cleared and otherwise ignored.

e7031: UART: In single wire receive mode UART will attempt to transmit if data is written to UART_D

Description: If transmit data is loaded into the UART_D register while the UART is configured for single wire receive mode, the UART will attempt to send the data. The data will not be driven on the pin, but it will be shifted out of the FIFO and the UART_S1[TDRE] bit will set when the character shifting is complete.

Workaround: Do not queue up characters to transmit while the UART is in receive mode. Always write UART_C3[TXDIR] = 1 before writing to UART_D in single wire mode.

e3892: UART: ISO-7816 automatic initial character detect feature not working correctly

Description: The ISO-7816 automatic initial character detection feature does not work. The direct convention initial character can be detected correctly, but the inverse convention initial character will only be detected if the S2[MSBF] and S2[RXINV] bits are set. This defeats the purpose of the initial character detection and automatic configuration of the S2[MSBF], S2[RXINV], and C3[TXINV] bits.

Workaround: Use software to manually detect initial characters. Configure the UART with S2[MSBF] and S2[RXINV] cleared. Then check UART receive characters looking for 0x3B or 0x03. If 0x3B is received, then the connected card is direct convention. If 0x03 is received, then the connected card is inverse convention. If an inverse convention card is detected, then software should set S2[MSBF], S2[RXINV], and C3[TXINV].

e4945: UART: ISO-7816 T=1 mode receive data format with a single stop bit is not supported

Description: Transmission of ISO-7816 data frames with single stop bit is supported in T=1 mode. Currently in order to receive a frame, two or more stop bits are required. This means that 11 ETU reception based on T=1 protocol is not supported. T=0 protocol is unaffected.

Workaround: Do not send T=1, 11 ETU frames to the UART in ISO-7816 mode. Use 12 ETU transmissions for T=1 protocol instead.

e5704: UART: TC bit in UARTx_S1 register is set before the last character is sent out in ISO7816 T=0 mode

Description: When using the UART in ISO-7816 mode, the UARTx_S1[TC] flag sets after a NACK is received, but before guard time expires.

Workaround: If using the UART in ISO-7816 mode with T=0 and a guard time of 12 ETU, check the UARTn_S1[TC] bit after each byte is transmitted. If a NACK is detected, then the transmitter should be reset.

The recommended code sequence is:

```
UART0_C2 &= ~UART_C2_TE_MASK; //make sure the transmitter is disabled at first
UART0_C3 |= UART_C3_TXDIR_MASK; //set the TX pin as output
UART0_C2 |= UART_C2_TE_MASK; //enable TX
UART0_C2 |= UART_C2_RE_MASK; //enable RX to
```



```
detect NACK for(i=0;i<length;i++) { while(!(UART0_S1&UART_S1_TDRE_MASK)){ UART0_D
= data[i]; while(!(UART0_S1&UART_S1_TC_MASK)){}//check for NACK if(UART0_IS7816 &
UART_IS7816_TXT_MASK)//check if TXT flag set { /* Disable transmit to clear the internal
NACK detection counter */ UART0_C2 &= ~UART_C2_TE_MASK; UART0_IS7816 =
UART_IS7816_TXT_MASK;// write one to clear TXT UART0_C2 |= UART_C2_TE_MASK; //
re-enable transmit } } UART0_C2 &= ~UART_C2_TE_MASK; //disable after transmit
```

e7091: UART: UART_S1[NF] and UART_S1[PE] can set erroneously while UART_S1[FE] is set

Description: While the UART_S1[FE] framing error flag is set the UART will discard any received data. Even though the data is discarded, if characters are received that include noise or parity errors, then the UART_S1[NF] or UART_S1[PE] bits can still set. This can lead to triggering of unwanted interrupts if the parity or noise error interrupts are enabled and framing error interrupts are disabled.

Workaround: If a framing error is detected (UART_S1[FE] = 1), then the noise and parity error flags can be ignored until the FE flag is cleared. Note: the process to clear the FE bit will also clear the NF and PE bits.

e7092: UART: UART_S1[TC] is not cleared by queuing a preamble or break character

Description: The UART_S1[TC] flag can be cleared by first reading UART_S1 with TC set and then performing one of the following: writing to UART_D, queuing a preamble, or queuing a break character. If the TC flag is cleared by queuing a preamble or break character, then the flag will clear as expected the first time. When TC sets again, the flag can be cleared by any of the three clearing mechanisms without reading the UART_S1 register first. This can cause a TC flag occurrence to be missed.

Workaround: If preamble and break characters are never used to clear the TC flag, then no workaround is required.

If a preamble or break character is used to clear TC, then write UART_D immediately after queuing the preamble or break character.

e8807: USB: In Host mode, transmission errors may occur when communicating with a Low Speed (LS) device through a USB hub

Description: In Host mode, if the required 48 MHz USB clock is not derived from the same clock source used by the core, transmission errors may occur when communicating with a Low Speed (LS) device through a USB hub. A typical example that causes this issue is when an external 48 MHz clock is used for the USB module via the USB_CLKIN pin, and a separate external clock on XTAL/EXTAL is used to generate the system/core clock.

This issue does not occur when in USB Device mode or if the LS device is not connected through a USB hub.

Workaround: In Host mode, ensure the 48 MHz USB clock is derived from the same clock source that the system clock uses. The two clocks, while they do not need to be the same frequency, both need to come from the same source so that they are in sync. For example, generate the 48 MHz USB clock by dividing down the PLL clock used by the core/system via the SIM_CLKDIV2[USBFRAC] and SIM_CLKDIV2[USBDIV] bit fields.

e5928: USBOTG: USBx_USBTRC0[USBRESET] bit does not operate as expected in all cases

Description: The USBx_USBTRC0[USBRESET] bit is not properly synchronized. In some cases using the bit can cause the USB module to enter an undefined state.

Workaround: Do not use the USBx_USBTRC0[USBRESET] bit. If USB registers need to be written to their reset states, then write those registers manually instead of using the module reset bit.

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